

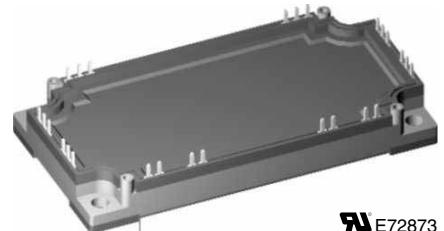
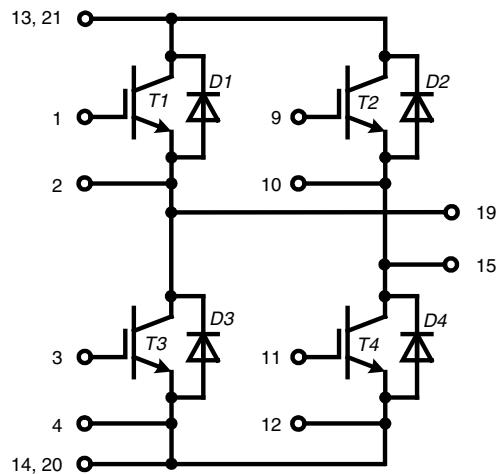
# IGBT Module

## H Bridge

$V_{CES}$  = 1200 V  
 $I_{C25}$  = 183 A  
 $V_{CE(sat)}$  = 1.8 V

**Part name** (Marking on product)

MIEB101H1200EH



### Features:

- SPT<sup>+</sup> IGBT technology
- low saturation voltage
- low switching losses
- square RBSOA, no latch up
- high short circuit capability
- positive temperature coefficient for easy paralleling
- MOS input, voltage controlled
- SONIC<sup>TM</sup> free wheeling diode
  - fast and soft reverse recovery
  - low operation forward voltage
- solderable pins for PCB mounting
- package with copper base plate

### Application:

- AC motor drives
- Solar inverter
- Medical equipment
- Uninterruptible power supply
- Air-conditioning systems
- Welding equipment
- Switched-mode and resonant-mode power supplies

### Package:

- "E3-Pack" standard outline
- Insulated copper base plate
- Soldering pins for PCB mounting

## Output Inverter T1 - T4

## Ratings

| Symbol         | Definitions   | Conditions   | min.  | typ.       | max.     | Unit     |
|----------------|---|--|---|------------|----------|----------|
| $V_{CES}$      | collector emitter voltage                                 | $T_{VJ} = 25^\circ C$  |   | 1200       |          | V        |
| $V_{GES}$      | max. DC gate voltage                                      | continuous   |   | $\pm 20$   |          | V        |
| $V_{GEM}$      | max. transient collector gate voltage                     | transient  |   | $\pm 30$   |          | V        |
| $I_{C25}$      | collector current   | $T_C = 25^\circ C$   | 183   |            | A        |          |
| $I_{C80}$      |   | $T_C = 80^\circ C$   | 128   |            | A        |          |
| $P_{tot}$      | total power dissipation                                   | $T_C = 25^\circ C$   | 630   |            | W        |          |
| $V_{CE(sat)}$  | collector emitter saturation voltage<br>(on chip level) ① | $I_C = 100 A; V_{GE} = 15 V$<br>$T_{VJ} = 25^\circ C$<br>$T_{VJ} = 125^\circ C$  | 1.8<br>2.0                                      | 2.2<br>2.4 | V        |          |
| $V_{GE(th)}$   | gate emitter threshold voltage                            | $I_C = 4 mA; V_{GE} = V_{CE}$  | $T_{VJ} = 25^\circ C$                           | 5          | 6        | V        |
| $I_{CES}$      | collector emitter leakage current                         | $V_{CE} = V_{CES}; V_{GE} = 0 V$   | $T_{VJ} = 25^\circ C$<br>$T_{VJ} = 125^\circ C$ | 0.9        | 0.3<br>3 | mA<br>mA |
| $I_{GES}$      | gate emitter leakage current                              | $V_{GE} = \pm 20 V$  |   | 200        | nA       |          |
| $C_{ies}$      | input capacitance   | $V_{CE} = 25 V; V_{GE} = 0 V; f = 1 MHz$   | 7430  |            | pF       |          |
| $Q_{G(on)}$    | total gate charge   | $V_{CE} = 600 V; V_{GE} = 15 V; I_C = 100 A$   | 750   |            | nC       |          |
| $t_{d(on)}$    | turn-on delay time  | $T_{VJ} = 125^\circ C$<br>inductive load<br>$V_{CE} = 600 V; I_C = 100 A$<br>$V_{GE} = \pm 15 V; R_G = 10 \Omega$<br>$L_S = 70 nH$ | 120   |            | ns       |          |
| $t_r$          | current rise time   |  | 55  |            | ns       |          |
| $t_{d(off)}$   | turn-off delay time                                       |  | 460   |            | ns       |          |
| $t_f$          | current fall time   |  | 240   |            | ns       |          |
| $E_{on}$       | turn-on energy per pulse                                  |  | 9.5   |            | mJ       |          |
| $E_{off}$      | turn-off energy per pulse                                 |  | 9.7   |            | mJ       |          |
| $E_{rec(off)}$ | reverse recovery losses at turn-off                       |  | 4.2   |            | mJ       |          |
| <b>RBSOA</b>   | reverse bias safe operating area                          | $V_{GE} = \pm 15 V; R_G = 10 \Omega;$<br>$V_{CEK} = 1200 V$  |   | 200        | A        |          |
| <b>SCSOA</b>   | short circuit safe operating area                         |  |   |            |          |          |
| $t_{sc}$       | short circuit duration                                    | $V_{CE} = 900 V; V_{GE} = \pm 10 V;$   |   | 10         | $\mu s$  |          |
|                | short circuit current                                     | $R_G = 3.9 \Omega$ ; non-repetitive  |   |            |          |          |
| $R_{thJC}$     | thermal resistance junction to case                       | (per IGBT)   |   | 0.2        | K/W      |          |

## Output Inverter D1 - D4

## Ratings

| Symbol     | Definitions                          | Conditions   | min.         | typ.         | max.    | Unit |
|------------|--------------------------------------|--|--------------|--------------|---------|------|
| $V_{RRM}$  | max. repetitive reverse voltage      | $T_{VJ} = 25^\circ C$  |              | 1200         |         | V    |
| $I_{F25}$  | forward current                      | $T_C = 25^\circ C$   |              | 135          | A       |      |
| $I_{F80}$  |                                      | $T_C = 80^\circ C$   |              | 90           | A       |      |
| $V_F$      | forward voltage<br>(on chip level) ① | $I_F = 100 A; V_{GE} = 0 V$<br>$T_{VJ} = 25^\circ C$<br>$T_{VJ} = 125^\circ C$   | 2.00<br>1.95 | 2.20<br>2.25 | V       |      |
| $I_{rr}$   | max. reverse recovery current        | $T_{VJ} = 125^\circ C$<br>inductive load<br>$V_{CE} = 600 V; I_C = 100 A$<br>$V_{GE} = \pm 15 V; R_G = 10 \Omega$<br>$L_S = 70 nH$ | 120          |              | A       |      |
| $t_{rr}$   | reverse recovery time                |  | 330          |              | ns      |      |
| $Q_{rr}$   |                                      |  | 12.5         |              | $\mu C$ |      |
| $E_{rec}$  |                                      |  | 4.2          |              | mJ      |      |
| $R_{thJC}$ | thermal resistance junction to case  | (per diode)  |              | 0.4          | K/W     |      |

 $T_C = 25^\circ C$  unless otherwise stated

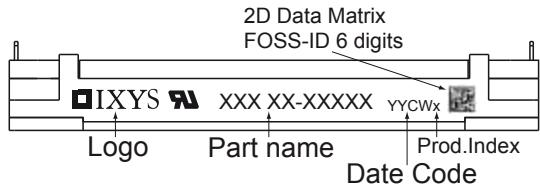
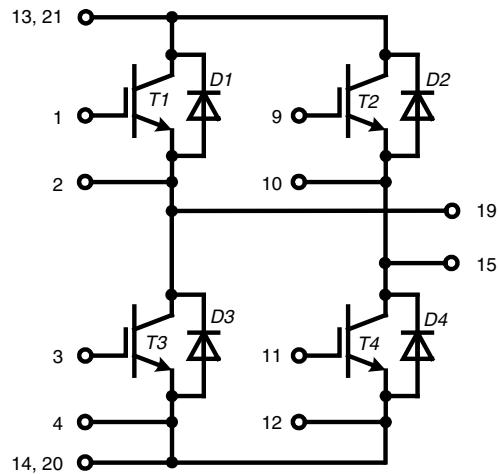
**Module****Ratings**

| <b>Symbol</b>            | <b>Definitions</b>                         | <b>Conditions</b>                              | <b>min.</b>                              | <b>typ.</b> | <b>max.</b>  | <b>Unit</b> |
|--------------------------|--|--|--|-------------|--------------|-------------|
| $T_{VJ}$                 | <i>operating temperature</i>               |  | -40                                      |             | 125          | °C          |
| $T_{VJM}$                | <i>max. virtual junction temperature</i>   |  |  |             | 150          | °C          |
| $T_{stg}$                | <i>storage temperature</i>                 |  | -40                                      |             | 125          | °C          |
| $V_{ISOL}$               | <i>isolation voltage</i>                   | $I_{ISOL} \leq 1 \text{ mA}; 50/60 \text{ Hz}$ | $t = 1 \text{ min}$<br>$t = 1 \text{ s}$ |             | 3000<br>3600 | V~<br>V~    |
| <b>CTI</b>               | <i>comparative tracking index</i>          |  |  |             | 200          |             |
| $M_d$                    | <i>mounting torque (M5)</i>                |  | 3  |             | 6            | Nm          |
| $R_{\text{pin to chip}}$ | <i>see ①</i>                               |  |  | 1.8         |              | mΩ          |
| $d_s$                    | <i>creep distance on surface</i>           |  | 12.7                                     |             |              | mm          |
| $d_A$                    | <i>strike distance through air</i>         |  | 9.6                                      |             |              | mm          |
| $R_{thCH}$               | <i>thermal resistance case to heatsink</i> | with heatsink compound                         |  | 0.1         |              | K/W         |
| <b>Weight</b>            |  |  |  | 300         |              | g           |

①  $V_{CE} = V_{CE(\text{sat})} + 2 \times R_{\text{pin to chip}} \cdot I_C$  $T_C = 25^\circ\text{C}$  unless otherwise stated

Curves are measured on modul level except Fig. 14 to Fig. 17

## Circuit Diagram

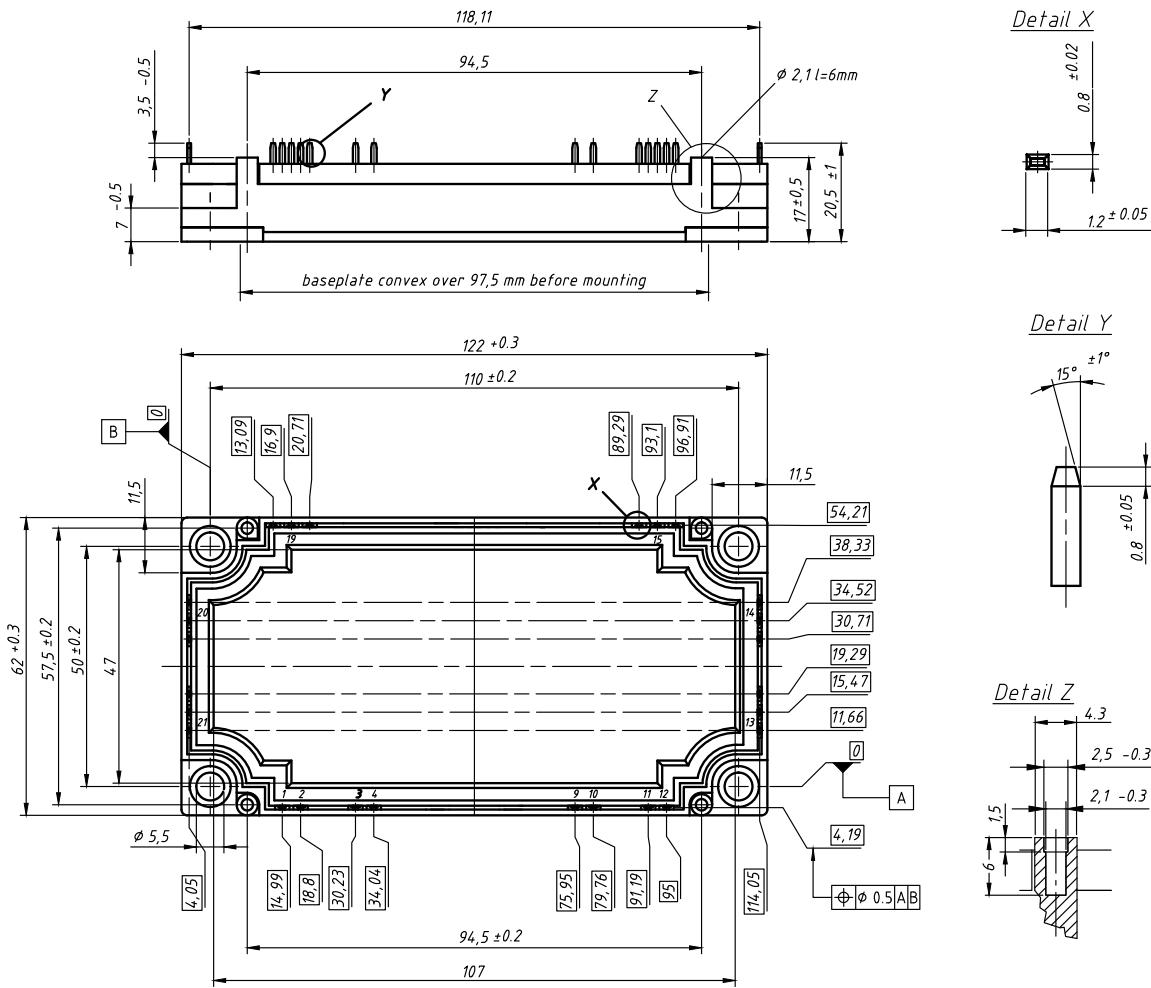


## Part number

M = Module  
I = IGBT  
E = SPT  
B = 2nd Generation  
101 = Current Rating [A]  
H = H~ Bridge  
1200 = Reverse Voltage [V]  
EH = E3-Pack

## Outline Drawing

Dimensions in mm (1 mm = 0.0394")



Remark:  
Dimensions without tolerances acc. DIN ISO 2768-T1-m

## Product Marking

| Ordering | Part Name      | Marking on Product | Delivering Mode | Base Qty | Ordering Code |
|----------|----------------|--------------------|-----------------|----------|---------------|
| Standard | MIEB101H1200EH | MIEB101H1200EH     | Box             | 5        | 510534        |

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## Transistor T1 - T4

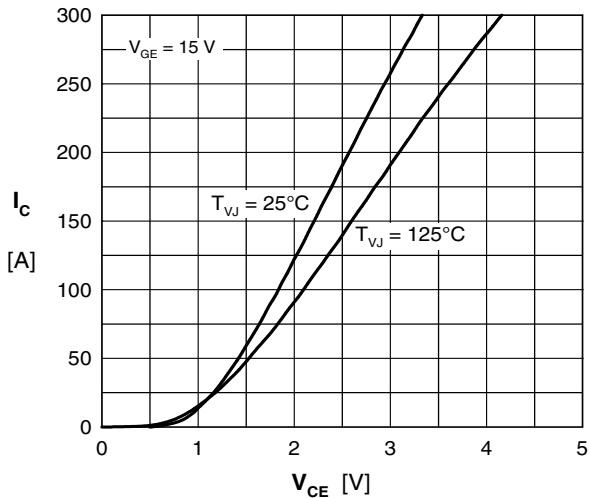


Fig. 1 Typ. output characteristics

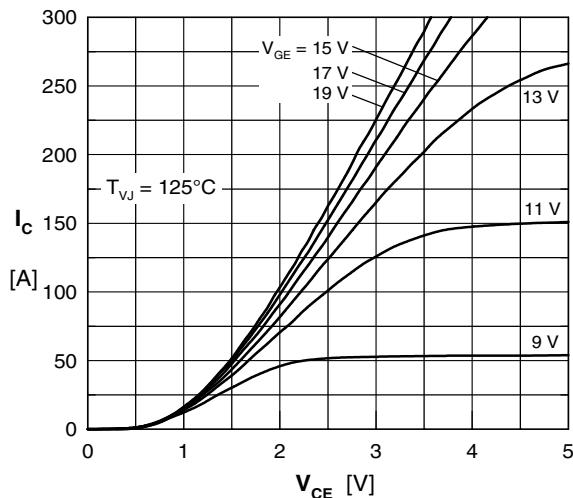


Fig. 2 Typ. output characteristics

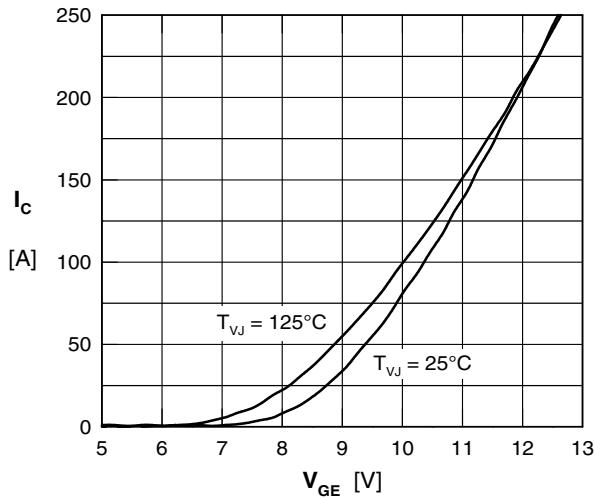


Fig. 3 Typ. transfer characteristics

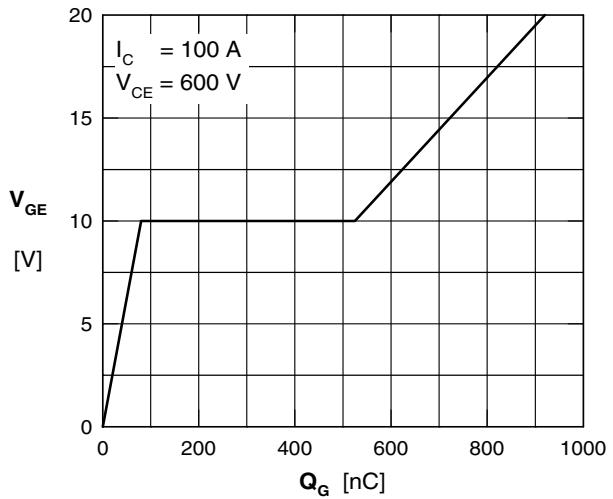


Fig. 4 Typ. turn-on gate charge

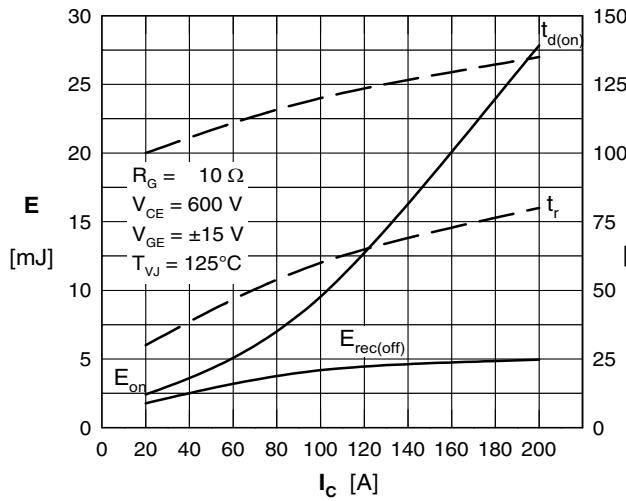


Fig. 5 Typ. turn-on energy &amp; switching times versus collector current

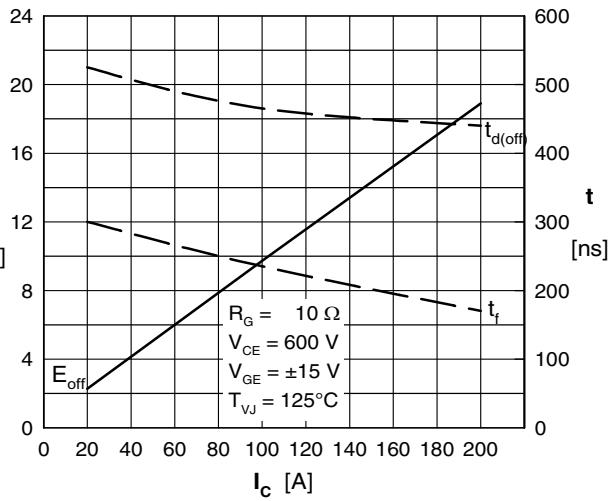


Fig. 6 Typ. turn-off energy &amp; switching times versus collector current

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## Transistor T1 - T4

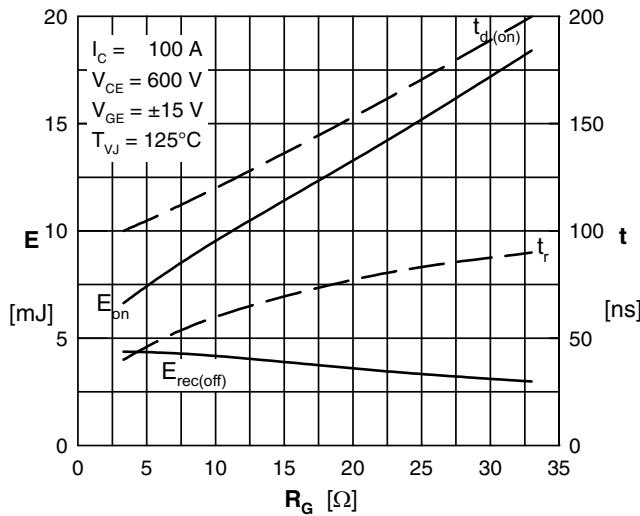


Fig. 7 Typ. turn-on energy and switching times versus gate resistor

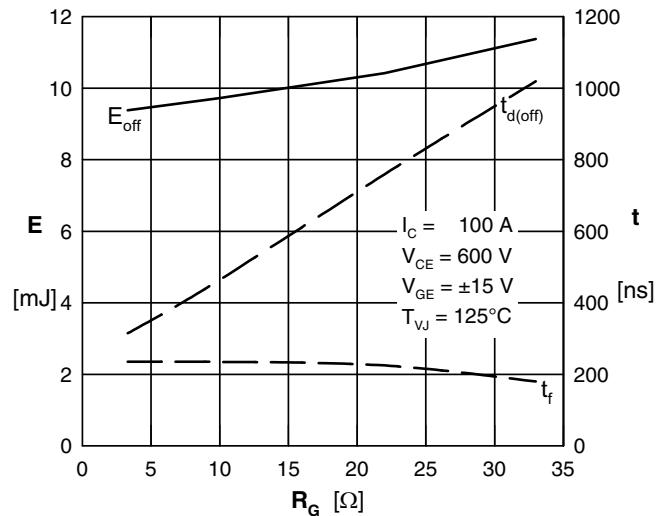


Fig. 8 Typ. turn-off energy and switching times versus gate resistor

## Diode D1 - D4

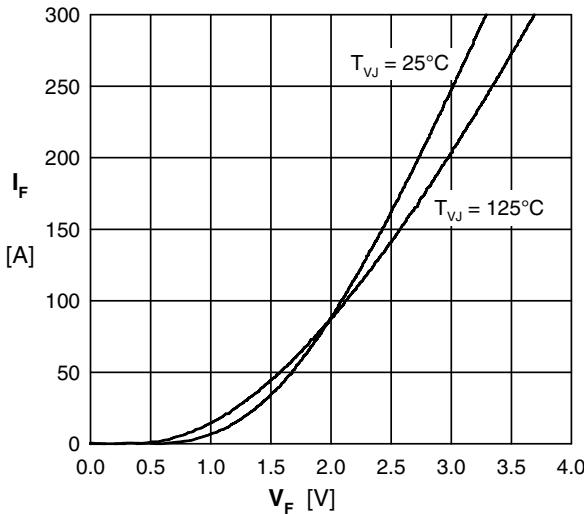


Fig. 9 Typ. forward characteristics

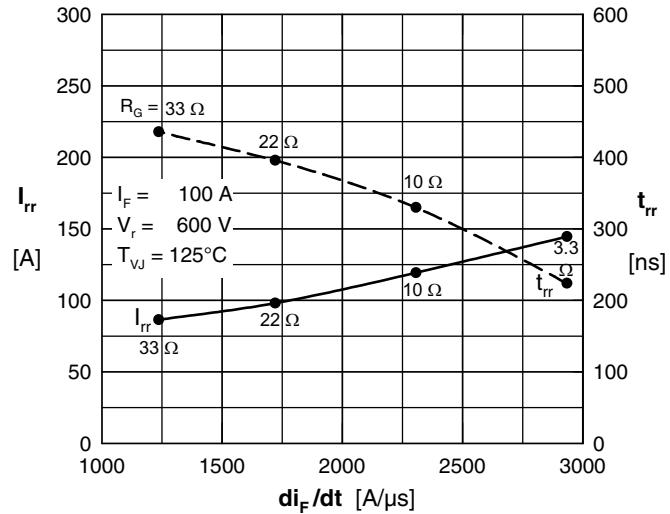


Fig. 10 Typ. reverse recovery characteristics

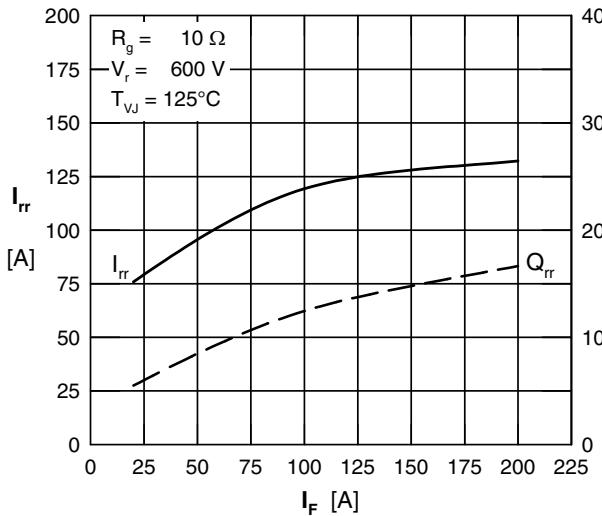


Fig. 11 Typ. reverse recovery characteristics

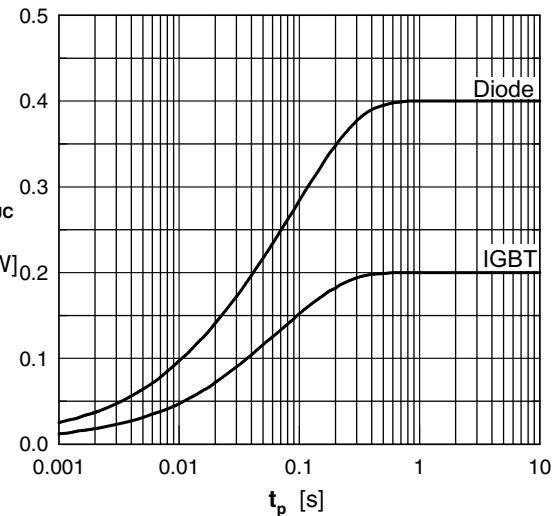


Fig. 12 Typ. transient thermal impedance

| IGBT  |          | FRD   |          |
|-------|----------|-------|----------|
| $R_i$ | $\tau_i$ | $R_i$ | $\tau_i$ |
| 0.003 | 0.00001  | 0.015 | 0.0005   |
| 0.010 | 0.0014   | 0.04  | 0.006    |
| 0.057 | 0.021    | 0.09  | 0.025    |
| 0.130 | 0.1      | 0.255 | 0.125    |

Fig. 13 Thermal coefficients

## Diode D1 - D4

